ESD562 12V Bi-Directional ESD Protection in SOT-23

1 Features

- IEC 61000-4-5 surge protection:
  - 3.5A (8/20µs)
- IEC 61000-4-2 ESD protection:
  - ±22kV contact discharge
  - ±30kV air gap discharge
- 12V working voltage
- IO capacitance:
  - 1.5pF (typical)
- Bidirectional polarity to support positive and negative voltage swings
- 2 channel device provides complete ESD protection with single component
- Small, leaded SOT-23 allows low cost automatic optical inspection (AOI)
- IO capacitance:1.5

2 Applications

- End equipment:
  - Factory automation and control
  - Building automation
  - Grid infrastructure
  - HVAC systems
  - Security systems
- Interfaces:
  - RS-485
  - RS-422

3 Description

The ESD562 is a bidirectional ESD protection diode for RS-485 and RS-422 interface protection. The ESD562 is rated to dissipate ESD strikes beyond the maximum level specified in the IEC 61000-4-2 international standard (±22kV Contact, ±30kV Air-gap). The device can clamp 8/20µs surges with peak pulse currents up to 3A in accordance with the IEC 61000-4-5 standard.

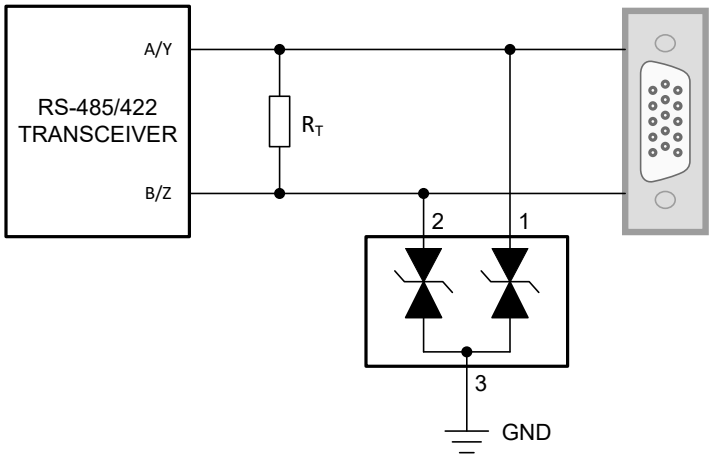
This device features a 1.5pF (typical) IO capacitance enabling high-speed interface protection. The low clamping voltage in the positive and negative direction help protect systems against transient events. This protection is key in industrial systems which require a high level of robustness and reliability.

The ESD562 is available in a small leaded SOT-23 (DBZ) package.

Package Information

PART NUMBER	PACKAGE(1)	PACKAGE SIZE(2)
ESD562	DBZ (SOT-23, 3)	2.92mm × 2.37mm

(1) For more information, see Section 9.
(2) The package size (length × width) is a nominal value and includes pins, where applicable.



Typical Application Schematic

An IMPORTANT NOTICE at the end of this data sheet addresses availability, warranty, changes, use in safety-critical applications, intellectual property matters and other important disclaimers. PRODUCTION DATA.

Table of Contents

1 Features....1
2 Applications....1
3 Description....1
4 Pin Configuration and Functions....2
5 Specifications....3
5.1 Absolute Maximum Ratings....3
5.2 ESD Ratings - JEDEC Specifications....3
5.3 ESD Ratings - IEC Specifications....3
5.4 Recommended Operating Conditions....3
5.5 Thermal Information....3
5.6 Electrical Characteristics....4
5.7 Typical Characteristics....5
6 Application and Implementation....7
6.1 Application Information....7
7 Device and Documentation Support....8
7.1 Documentation Support....8
7.2 Receiving Notification of Documentation Updates....8
7.3 Support Resources....8
7.4 Trademarks....8
7.5 Electrostatic Discharge Caution....8
7.6 Glossary....8
8 Revision History....8
9 Mechanical, Packaging, and Orderable Information....8

4 Pin Configuration and Functions

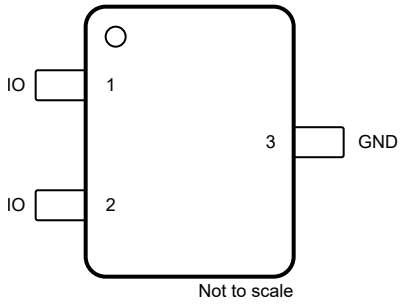


Figure 4-1. ESD562 DBZ Package, 3-Pin SOT-23 (Top View)

Table 4-1. Pin Functions for ESD562

PIN		TYPE(1)	DESCRIPTION
NAME	NO.		
IO	1, 2	I/O	Surge and ESD protected IO
GND	3	GND	Ground. Connect to ground

(1) I = Input, O = Output, I/O = Input or Output, GND = ground

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5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

		MIN	MAX	UNIT
P_{PP}	IEC 61000-4-5 Surge (t_p 8/20µs) Peak Pulse Power at 25 °C		84	W
I_{PP}	IEC 61000-4-5 Surge (t_p 8/20µs) Peak Pulse Current at 25°C		3.5	A
T_A	Operating free-air temperature	-40	125	°C
T_{stg}	Storage temperature	-65	155	°C

(1) Operation outside the *Absolute Maximum Ratings* may cause permanent device damage. Absolute maximum ratings do not imply functional operation of the device at these or any other conditions beyond those listed under *Recommended Operating Conditions*. If briefly operating outside the *Recommended Operating Conditions* but within the *Absolute Maximum Ratings*, the device may not sustain damage, but it may not be fully functional. Operating the device in this manner may affect device reliability, functionality, performance, and shorten the device lifetime.

5.2 ESD Ratings - JEDEC Specifications

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins(1)	±2500	V
		Charged device model (CDM), per JEDEC specification JS-002, all pins(2)	±1000	

(1) JEDEC document JEP155 states that 500V HBM allows safe manufacturing with a standard ESD control process.
(2) JEDEC document JEP157 states that 250V CDM allows safe manufacturing with a standard ESD control process.

5.3 ESD Ratings - IEC Specifications

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	IEC 61000-4-2 Contact Discharge, all pins	±22000	V
		IEC 61000-4-2 Air Discharge, all pins	±30000	

5.4 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
V_{IN}	Input voltage between any 2 pins	-12		12	V
T_A	Operating Free Air Temperature	-40		125	°C

5.5 Thermal Information

THERMAL METRIC(1)		ESD562 DBZ (SOT-23) 3 PINS	UNIT
$R_{\theta JA}$	Junction-to-ambient thermal resistance	250.4	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	136.6	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	84.0	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	29.5	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	83.3	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

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5.6 Electrical Characteristics

At T_A = 25°C unless otherwise noted

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{RWM}	Reverse stand-off voltage	I_{IO} < 50nA	-12		12	V
$I_{LEAKAGE}$	Leakage current at V_{RWM}	V_{IO} = ±12V, I/O to GND		10	50	nA
V_{BR}	Breakdown Voltage, IO to GND and GND to IO(1)	I_{IO} = ±1mA	13.2		18	V
V_{CLAMP}	Surge clamping voltage, t_p = 8/20µs(2)	I_{PP} = ±3A, I/O to GND			21	V
	TLP clamping voltage, t_p = 100ns(3)	I_{PP} = 16A (100ns TLP), I/O to GND		22		V
	TLP clamping voltage, t_p = 100ns(3)	I_{PP} = 16A (100ns TLP), GND to I/O		22		V
V_{HOLD}	Holding Voltage, I/O to GND(4)	TLP, IO to GND or GND to IO		16.5		V
C_{Line}	Line capacitance, IO to GND	V_{IO} = 0V, f = 1MHz		1.5		pF

(1) V_{BR} is defined as the voltage obtained at 1mA when sweeping the voltage up, before the devices latches into the snapback state

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5.7 Typical Characteristics

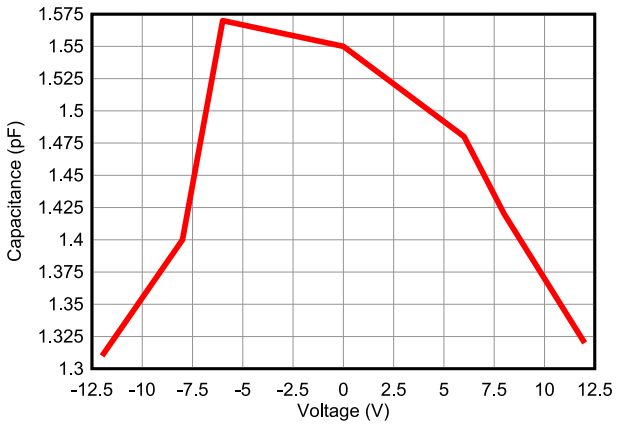

Figure 5-1. Capacitance vs. Bias Voltage

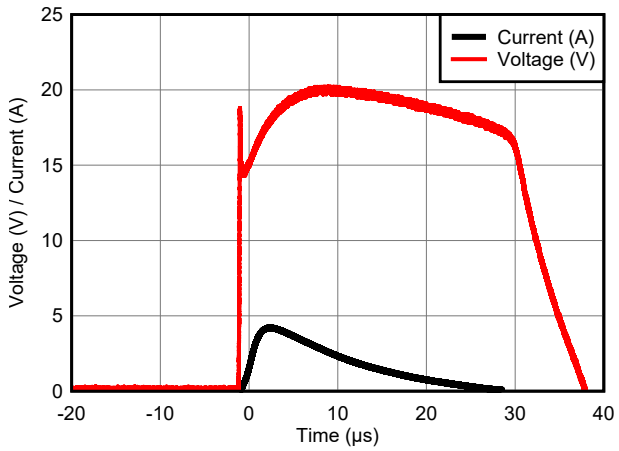

Figure 5-2. 8/20µs Surge Response

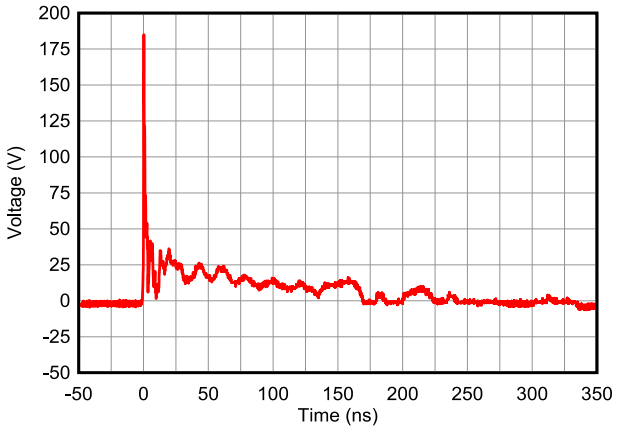

Figure 5-3. +8kV Clamped IEC Waveform

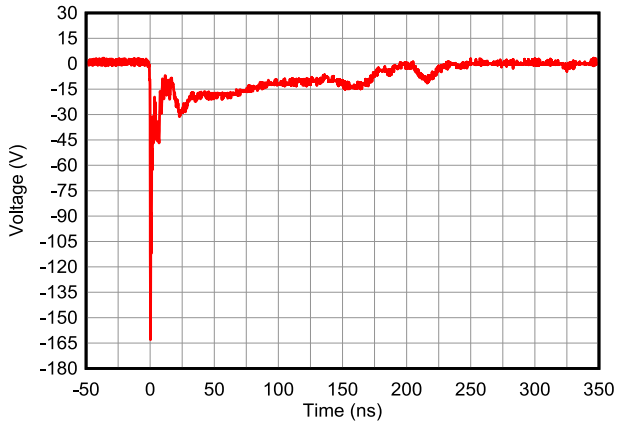

Figure 5-4. -8kV Clamped IEC Waveform

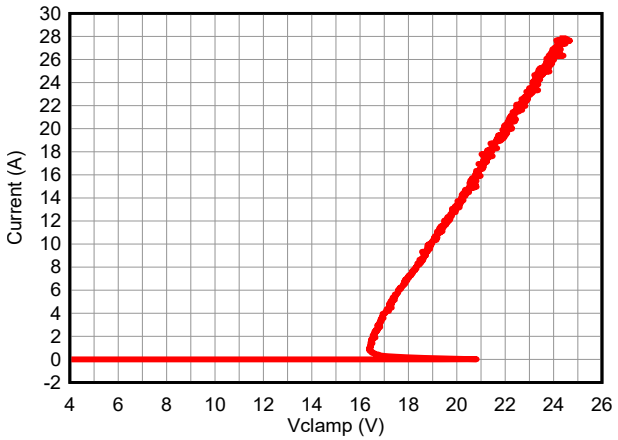

Figure 5-5. Positive TLP Curve

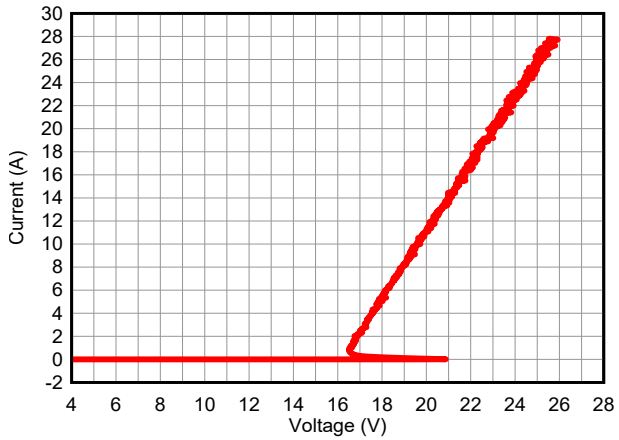

Figure 5-6. Negative TLP Curve

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5.7 Typical Characteristics (continued)

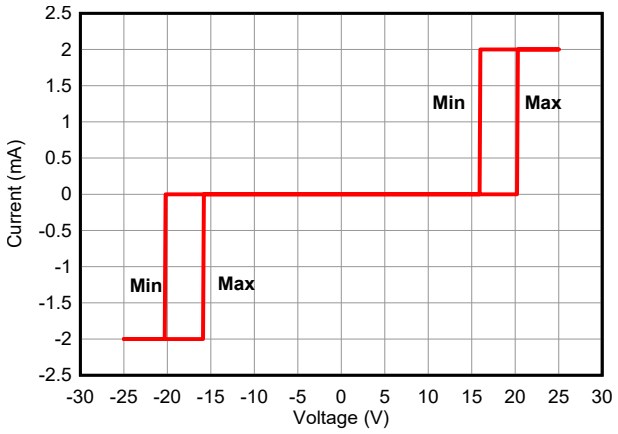

Figure 5-7. DC Voltage Sweep I-V Curve

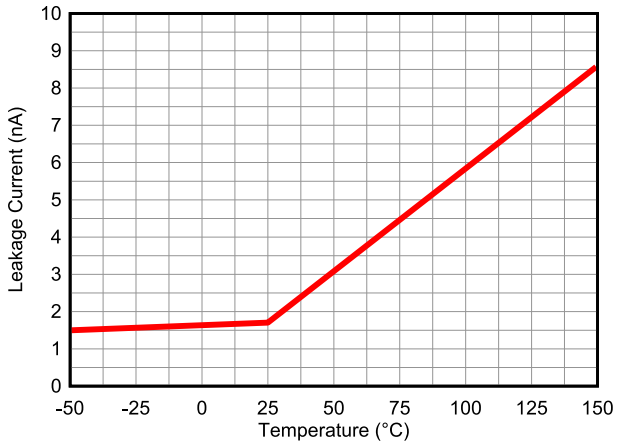

Figure 5-8. Leakage Current vs Temperature

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6 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

6.1 Application Information

The ESD562 is a diode type TVS that provides a path to ground for dissipating transient voltage spikes, such as ESD or surge, on signal lines and power lines. Connect the device in parallel to the down stream circuitry for protection. As the current from the transient passes through the device, only a small voltage drop is present across the diode. This is the voltage presented to the protected IC. The low R_{DYN} of the triggered TVS holds this voltage (V_{CLAMP}) to a safe level for the protected IC. For more information on how to properly use this device, refer to the *ESD Packaging and Layout Guide* for details.

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7 Device and Documentation Support

7.1 Documentation Support

7.1.1 Related Documentation

For related documentation, see the following:

- Texas Instruments, *ESD Packaging and Layout Guide*
- Texas Instruments, *TI's IEC 61000-4-x Testing application note*
- Texas Instruments, *ESD Layout Guide user's guide*
- Texas Instruments, *ESD Protection Diodes EVM user's guide*
- Texas Instruments, *Generic ESD Evaluation Module user's guide*
- Texas Instruments, *Reading and Understanding an ESD Protection Data Sheet user's guide*

7.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

7.3 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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7.4 Trademarks

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7.5 Electrostatic Discharge Caution

This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

7.6 Glossary

TI Glossary	This glossary lists and explains terms, acronyms, and definitions.

8 Revision History

DATE	REVISION	NOTES
February 2024	*	Initial Release

9 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
ESD562DBZR	ACTIVE	SOT-23	DBZ	3	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	36X8	Samples

(1) The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".
RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.
Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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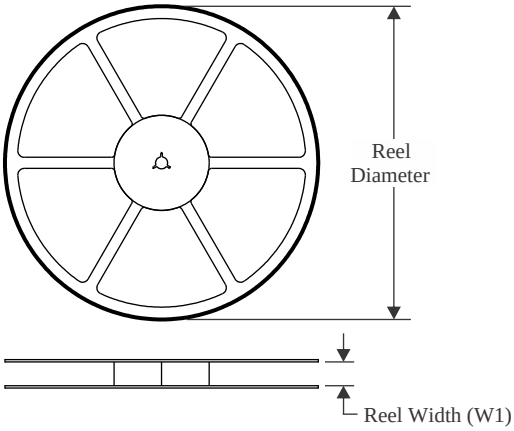
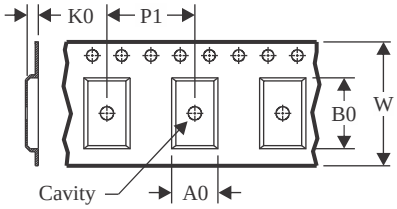
TAPE AND REEL INFORMATION

REEL DIMENSIONS

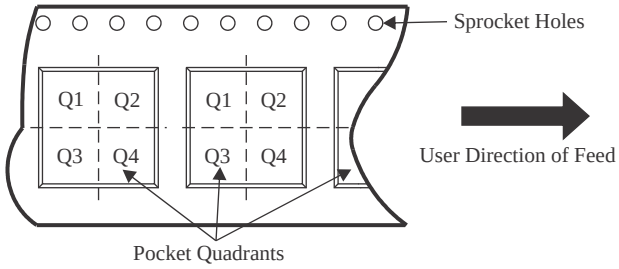


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

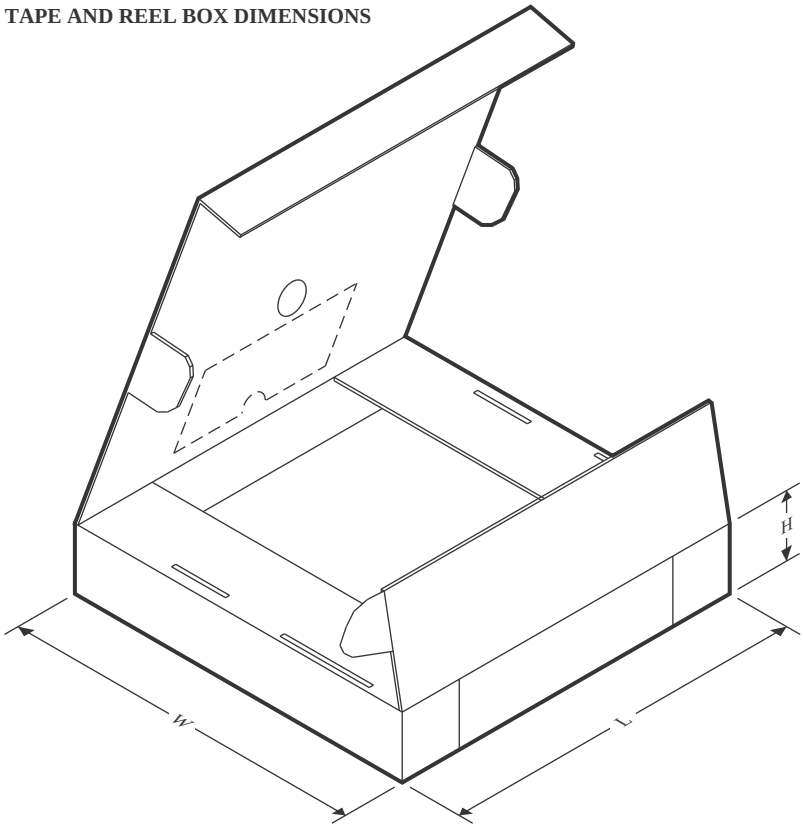
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
ESD562DBZR	SOT-23	DBZ	3	3000	180.0	8.4	2.9	3.35	1.35	4.0	8.0	Q3

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

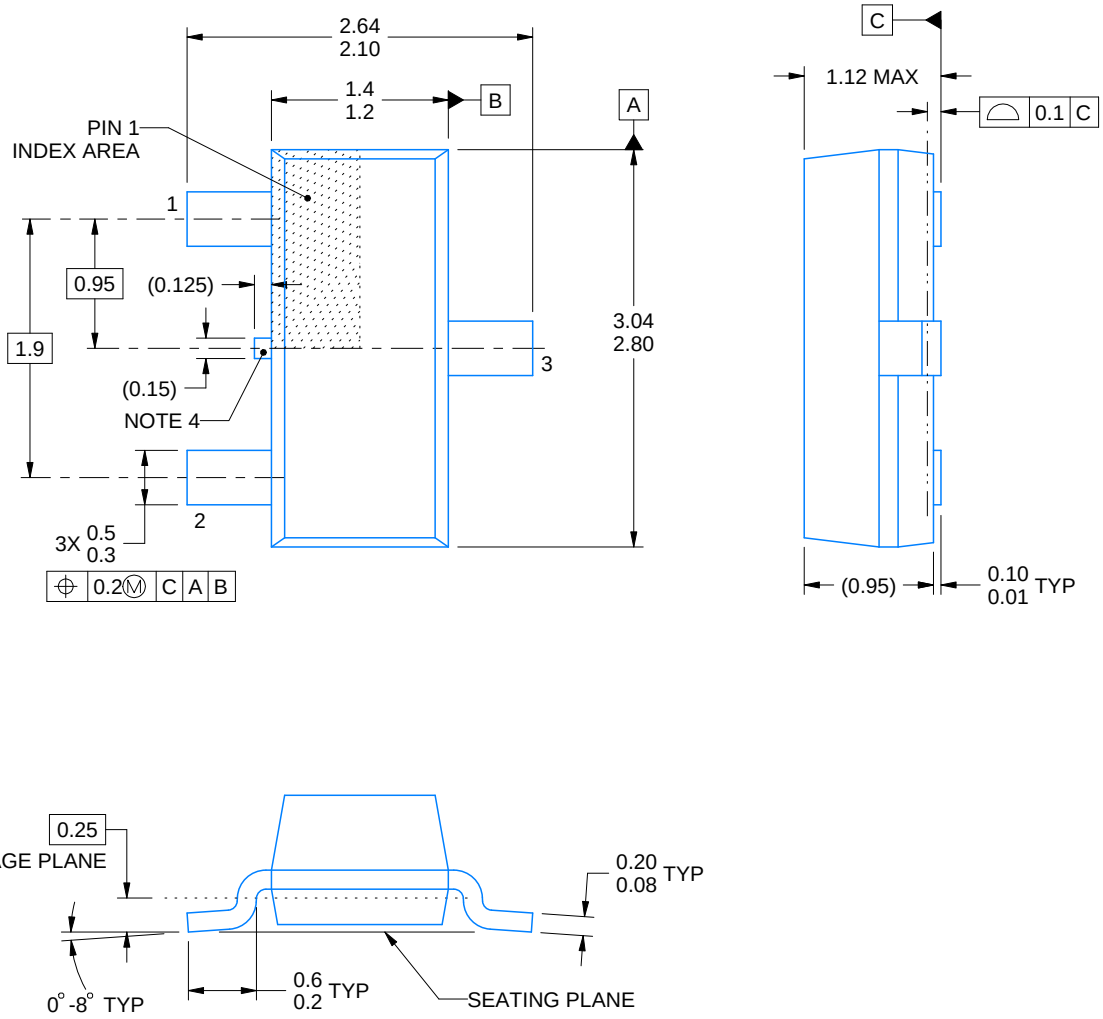
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ESD562DBZR	SOT-23	DBZ	3	3000	210.0	185.0	35.0

PACKAGE OUTLINE

DBZ0003A

SOT-23 - 1.12 mm max height

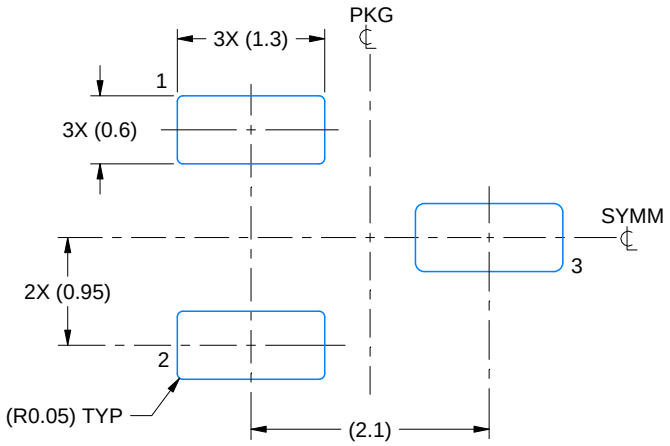
SMALL OUTLINE TRANSISTOR



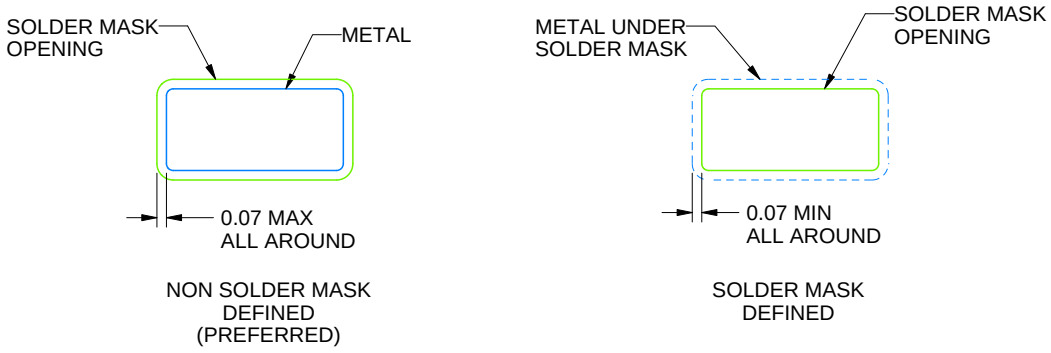
4214838/D 03/2023

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. Reference JEDEC registration TO-236, except minimum foot length.
4. Support pin may differ or may not be present.



LAND PATTERN EXAMPLE
SCALE:15X

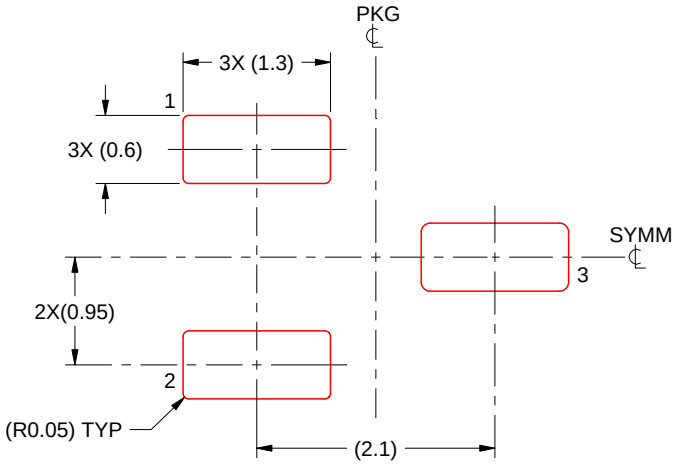


SOLDER MASK DETAILS

4214838/D 03/2023

NOTES: (continued)

4. Publication IPC-7351 may have alternate designs.
5. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOLDER PASTE EXAMPLE
BASED ON 0.125 THICK STENCIL
SCALE:15X

4214838/D 03/2023

NOTES: (continued)

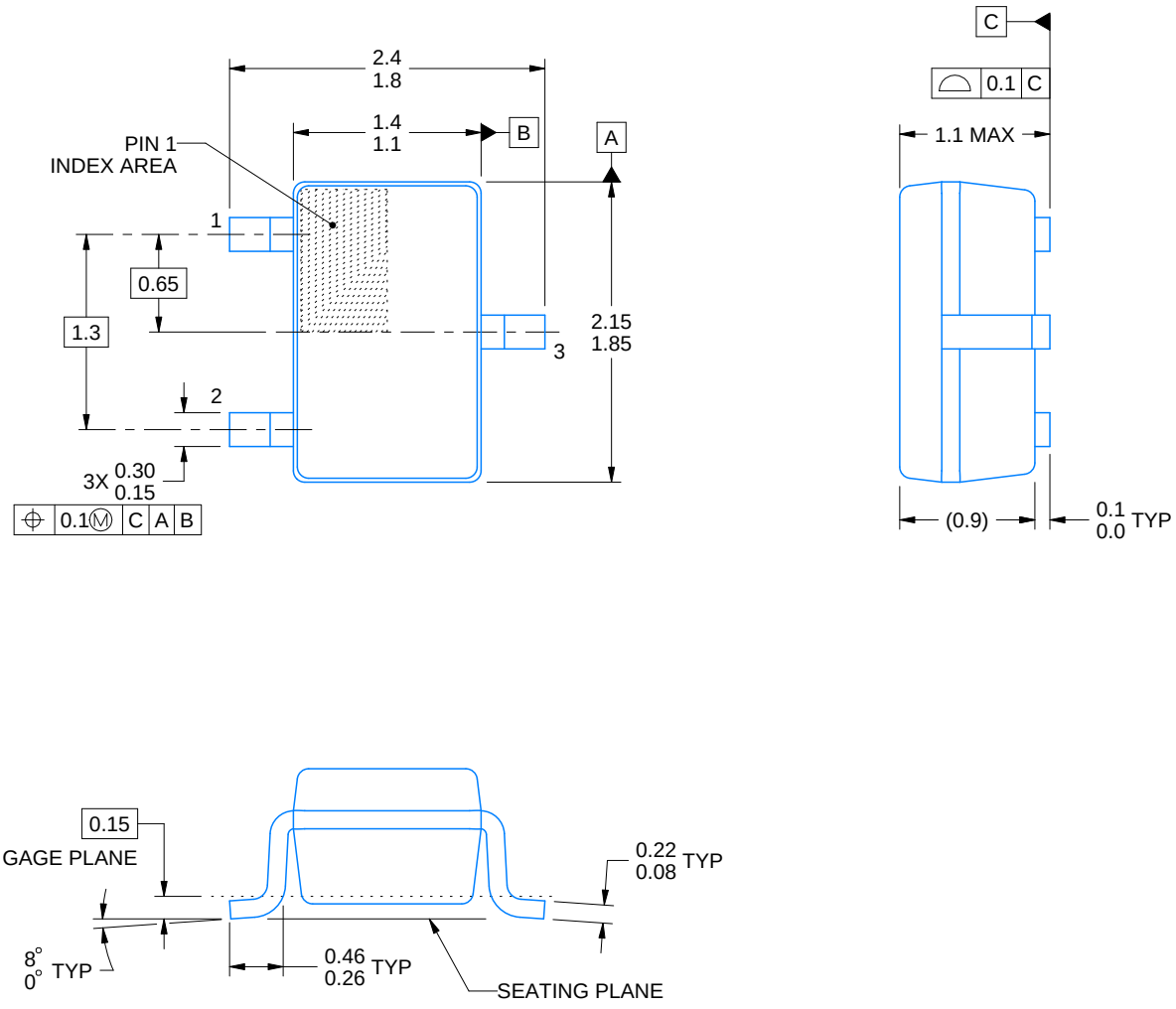
6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
7. Board assembly site may have different recommendations for stencil design.

DCK0003A

PACKAGE OUTLINE

SOT-SC70 - 1.1 max height

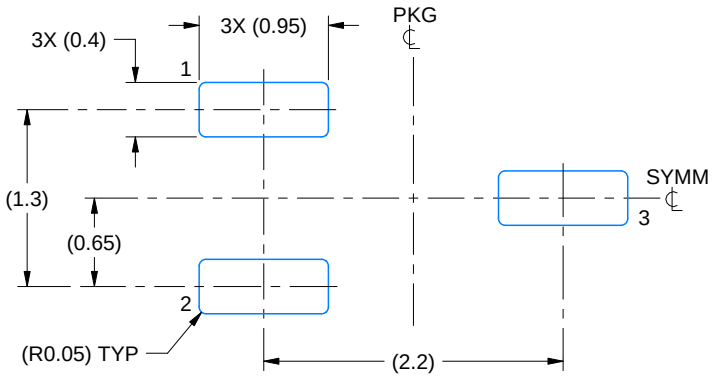
SMALL OUTLINE TRANSISTOR SC70



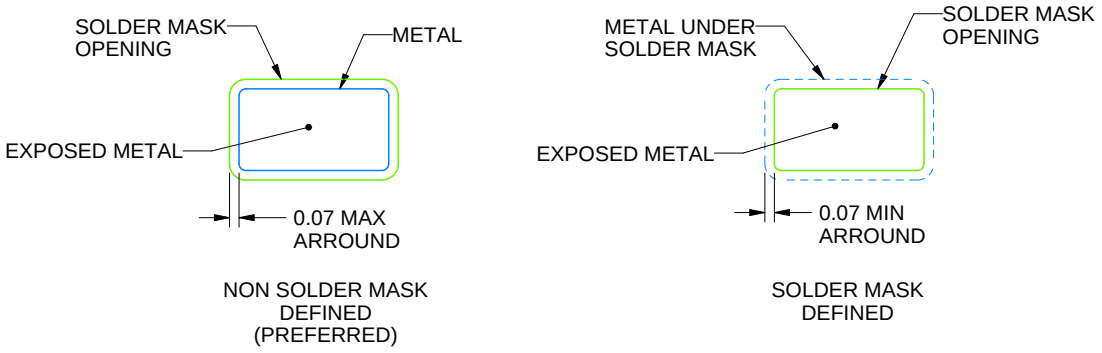
4220745/C 06/2021

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:18X



SOLDER MASK DETAILS

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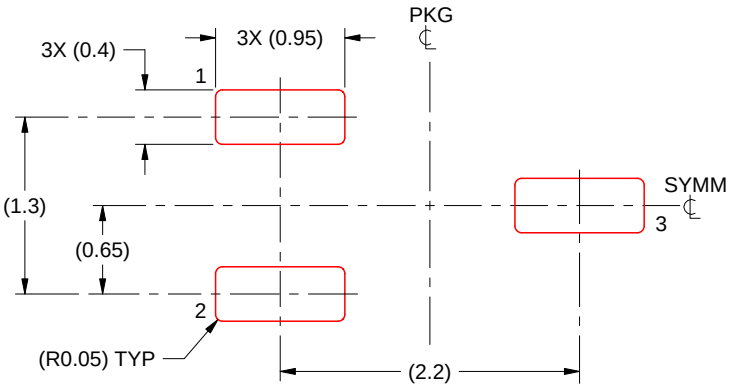
NOTES: (continued)

3. Publication IPC-7351 may have alternate designs.
4. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOLDER PASTE EXAMPLE
BASED ON 0.125 THICK STENCIL
SCALE:18X

4220745/C 06/2021

NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
6. Board assembly site may have different recommendations for stencil design.

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